

Automotive Power MOSFET Module

NXV08H250DT1

Features

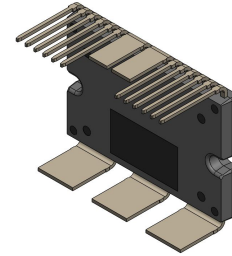
- 2 Phase MOSFET Module
 At Customer Side this Module Can Be Used as 1/2 Bridge MOSFET Module by Combining 2 Phase Out Power Terminals
- Electrically Isolated DBC Substrate for Low Rthjc
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Module Level AQG324 Qualified. Components Inside are AEC Q101 (MOSFET) & AEC Q200 (Passives) Qualified
- UL 94 V-0 Compliant
- This Device is Pb-Free and is RoHS Compliant
- ESD Tested for HBM and CDM per AEC Q101, JS-001, JS-002

Applications

- 48 V Inverter, 48 V Traction

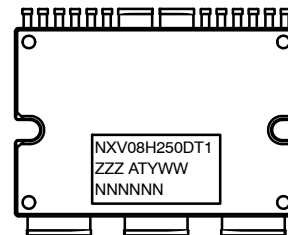
Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO₂ Emission
- Simplified Vehicle Assembly
- Low Thermal Resistance to Junction to Heat Sink by Direct Mounting via Thermal Interface Material between Module Case and Heat Sink
- Low Inductance



APM17-MDC
 CASE MODHH

MARKING DIAGRAM



NXV08H250DT1	= Specific Device Code
ZZZ	= Lot ID
AT	= Assembly & Test Location
Y	= Year
WW	= Work Week
NNN	= Serial Number

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

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ORDERING INFORMATION

Part Number	Package	Pb-Free and RoHS Compliant	Operating Ambient Temperature Range	Packing Method
NXV08H250DT1	APM17-MDC	yes	-40~125°C	Tube

Pin Configuration

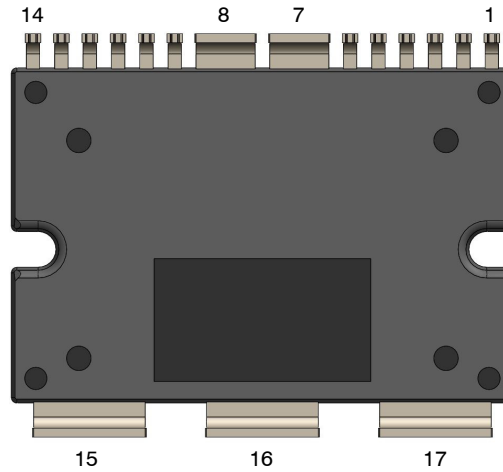


Figure 1. Pin Configuration

PIN DESCRIPTION

Pin No.	Description	Remark
1	Q2 Gate	
2	Q2 Source Sense	
3	B+ #2 Sense	
4	Q4 Gate	
5	Q4 Source Sense	
6	NTC1	
7	Phase Out2	For 3 phase motor inverter, those 2 pins can be used as one phase out
8	Phase Out1	
9	NTC2	
10	Q3 Source Sense	
11	Q3 Gate	
12	B+ #1 Sense	
13	Q1 Source Sense	
14	Q1 Gate	
15	B+ #1	
17	B+ #2	

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Block Diagram

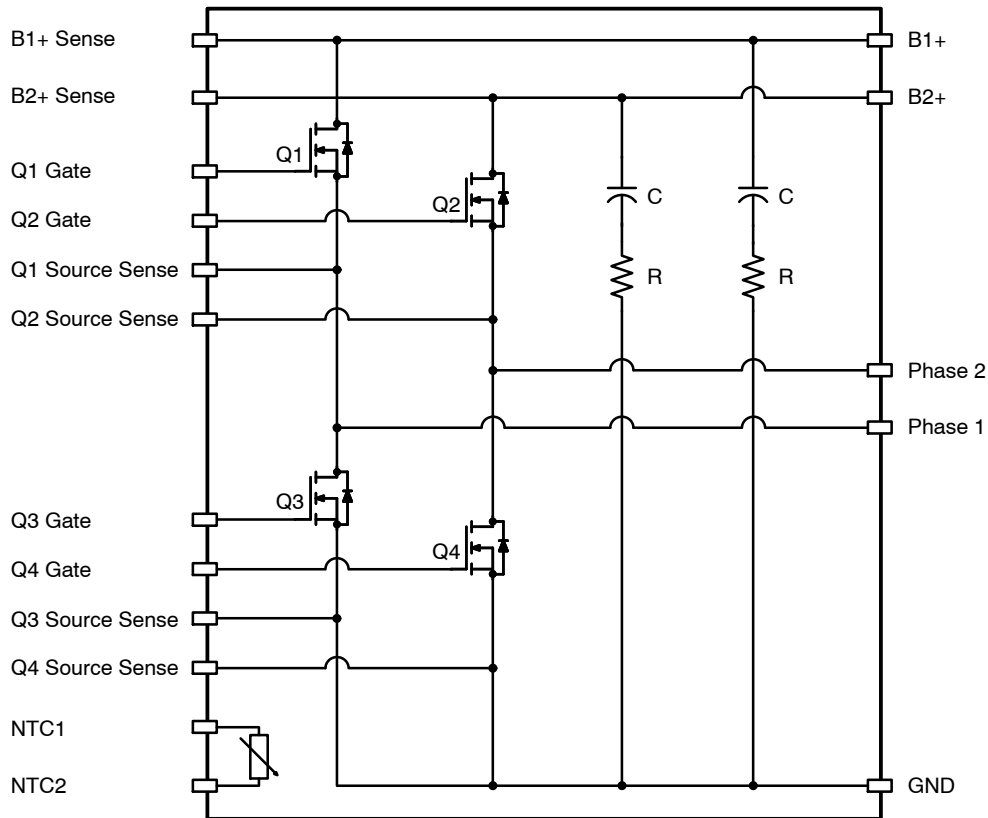


Figure 2. Schematic

Flammability Information

All materials present in the power module meet UL flammability rating class 94V-0.

Compliance to RoHS Directives

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

Solder

Solder used is a lead free SnAgCu alloy.

Base of the leads, at the interface with the package body should not be exposed to more than 200°C during mounting on the PCB, this to prevent the remelt of the solder joints.

ABSOLUTE MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Max.	Unit
V _{DS} (Q1~Q4)	Drain-to-Source Voltage	80	V
V _{GS} (Q1~Q4)	Gate-to-Source Voltage	±20	V
E _{AS} (Q1~Q4)	Single Pulse Avalanche Energy (Note 1)	1946	mJ
T _J	Maximum Junction Temperature	175	°C
T _{STG}	Storage Temperature	125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Starting T_J = 25°C, L = 0.47 mH, I_{AS} = 91 A, V_{DD} = 72 V during inductor charging and V_{DD} = 0 V during time in avalanche.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise noted)

Characteristic		Condition	Min	Typ	Max	Unit
BVDSS	Drain-to-Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	80	-	-	
VGS(th)	Gate-to-Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 1 mA	2	-	4.6	V
VSD	Source-to-Drain Diode Voltage	I _{SD} = 160 A, V _{GS} = 0 V	-	0.79	1.1	V
Measured RDS(ON) Q1, Q2	Q1, Q2 (High Side) MOSFET (Notes 2, 3)	V _{GS} = 12 V, I _D = 160 A, T _J = 25°C	-	0.757	1.039	mΩ
Measured RDS(ON) Q3, Q4	Q3, Q4 (Low Side) MOSFET (Notes 2, 3)	V _{GS} = 12 V, I _D = 160 A, T _J = 25°C	-	0.549	0.762	mΩ
IGSS	Gate-to-Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V, T _J = 25°C	-100	-	+100	nA
IDSS	Drain-to-Source Leakage Current	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 25°C	-	-	2	μA
Module RDS(ON) for Q1 and Q2: From B+1 (or B+2), via Q1 (or Q2), to Phase Out 1 (Phase Out 2) (Note 3)		V _{GS} = 12 V, I _D = 160 A, T _J = 25°C	-	1.024	1.355	mΩ
Module RDS(ON) for Q3 and Q4: From Phase Out 1 (Phase Out 2), via Q3 (Q4), to GND PINs (Note 3)		V _{GS} = 12 V, I _D = 160 A, T _J = 25°C	-	0.966	1.270	mΩ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. All bare die MOSFETs have same die size and same level of R_{dson} value. However the different R_{dson} values listed in the datasheet are due to the different access points available inside the module for R_{dson} measurement. Q3 and Q4 (Low side FETs) has the shortest R_{dson} measurement path in the layout, in this reason, so Q3 or Q4 R_{dson} value can be used for the R_{dson} value per switch for simple power loss calculation.

Each R_{dson} measurement paths are as below table, "Resistance Measurement Methods"

3. Module R_{dson} means total resistance of the measurement path btw Power terminals, referring to the resistance measurement methods table.

RESISTANCE MEASUREMENTS METHODS

	+ Force Pin#	- Force Pin#	+ Sense Pin#	- Sense Pin#
FET R _{dson} Q1	B1+	Phase1	B1+ Sense	Q1 Source Sense
FET R _{dson} Q2	B2+	Phase2	B2+ Sense	Q2 Source Sense
FET R _{dson} Q3	Phase1	GND	Q1 Source Sense	Q3 Source Sense
FET R _{dson} Q4	Phase2	GND	Q2 Source Sense	Q4 Source Sense
Module R _{dson} Q1	B1+	Phase1	B1+	Phase1
Module R _{dson} Q2	B2+	Phase2	B2+	Phase2
Module R _{dson} Q3	Phase1	GND	Phase1	GND
Module R _{dson} Q4	Phase2	GND	Phase2	GND

TEMPERATURE SENSE (NTC THERMISTOR)

Parameter	Min	Typ	Max	Unit		
Voltage	Current = 1 mA, Temperature = 25°C		7.5	-	12	V

THERMAL RESISTANCE

Parameter	Min	Typ	Max	Unit		
R _{thjc} : Thermal Resistance Junction-to-case, Single Inverter FET	Q1, Q2, Q3, Q4 Thermal Resistance J-C		-	-	0.54	°C/W

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ISOLATION VOLTAGE (Isolation voltage between the Base plate and to control pins or power terminals.)

Test	Test Condition	Test Time	Min	Max	Unit
Leakage @ Isolation Voltage (Hi-Pot)	VAC = 3 kV	Time = 1 s	-	250	μA

DYNAMIC AND SWITCHING CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
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DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}, f = 750\text{ kHz}$	-	24350	-	pF
C_{oss}	Output Capacitance		-	3415	-	pF
C_{rss}	Reverse Transfer Capacitance		-	53	-	pF
R_g	Gate Resistance	$f = 750\text{ kHz}, V_{ac} = 1\text{ V}_{rms}$	-	3.6	-	Ω
$Q_{g(tot)}$	Total Gate Charge	$V_{GS} = 0\text{ to }10\text{ V}, I_D = 160\text{ A}$	-	320	-	nC
Q_{gs}	Gate-to-Source Gate Charge		-	150	-	nC
Q_{gd}	Gate-to-Drain "Miller" Charge		-	54	-	nC

SWITCHING CHARACTERISTICS

t_{on}	Turn-On Time	$V_{DD} = 48\text{ V}, I_D = 400\text{ A}$ $V_{GS} = 12\text{ V}, R_G(\text{on/off}) = 15/15\text{ }\Omega$	-	462	-	ns
$t_{d(on)}$	Turn-On Delay Time		-	164	-	ns
t_r	Turn-On Rise Time		-	298	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	476	-	ns
t_f	Turn-Off Fall Time		-	196	-	ns
t_{off}	Turn-Off Time		-	672	-	ns

DRAIN-SOURCE DIODE CHARACTERISTICS

t_{RR}	Reverse Recovery Time	$V_{DD} = 48\text{ V}, I_D = 400\text{ A}$ $V_{GS} = 14\text{ V}, R_G(\text{on/off}) = 3.9/8.2\text{ }\Omega$	-	55	-	ns
Q_{RR}	Reverse Recovery Charge		-	2005	-	nC

4. Dynamic & Switching characteristics data is by characterization test result and guaranteed by design factors.

COMPONENTS

Component	Description	Type	Qty.	Specification
MOSFET	Bare Die, 7,874 x 5,588 μm	Bare Die	4	80 V
NTC	10 kΩ ±1% 1,600 x 800 μm	Discrete	1	B-Constant B _{25/50} = 3380K B _{25/85} = 3435K B _{25/100} = 3455K
Capacitor (Snubber)	1,600 x 800 μm	Discrete	2	15 nF
Resistor (Snubber)	2,000 x 1,250 μm	Discrete	2	1 Ω

TYPICAL CHARACTERISTICS

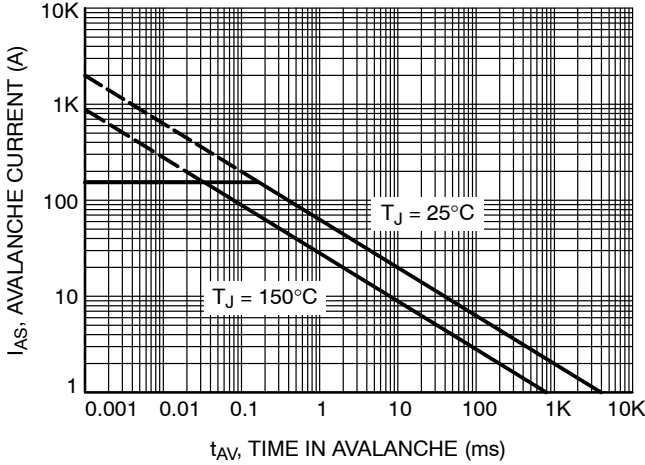


Figure 3. Unclamped Inductive Switching Capability

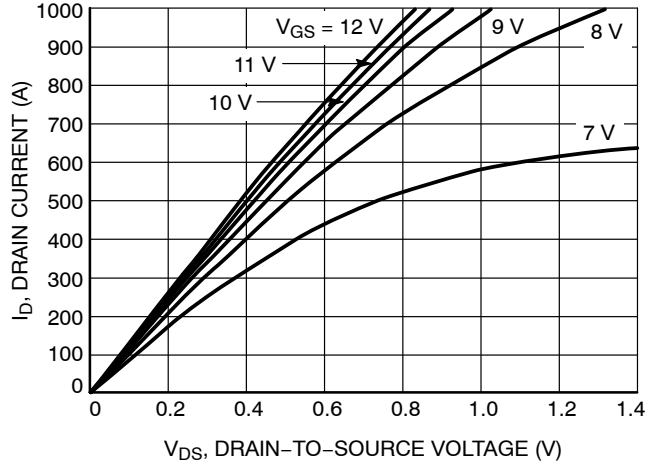


Figure 4. Saturation Characteristics

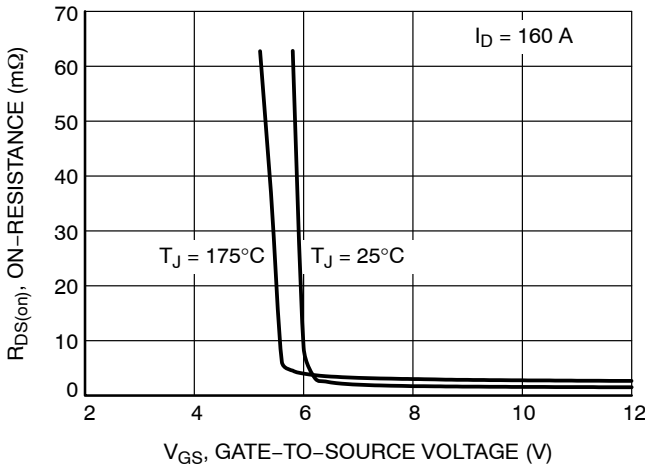


Figure 5. $R_{DS(on)}$ vs. Gate Voltage

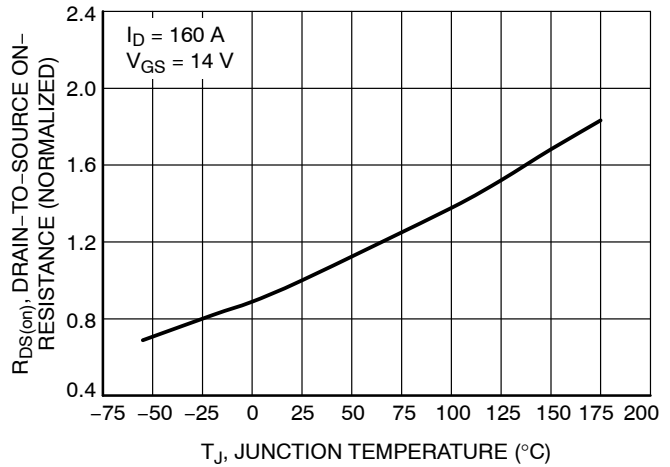


Figure 6. $R_{DS(on)}$ vs. Temperature

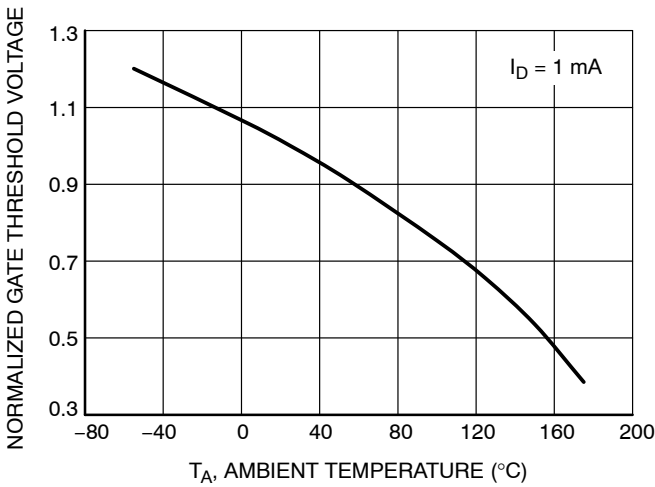


Figure 7. Normalized Gate Threshold Voltage vs. Temperature

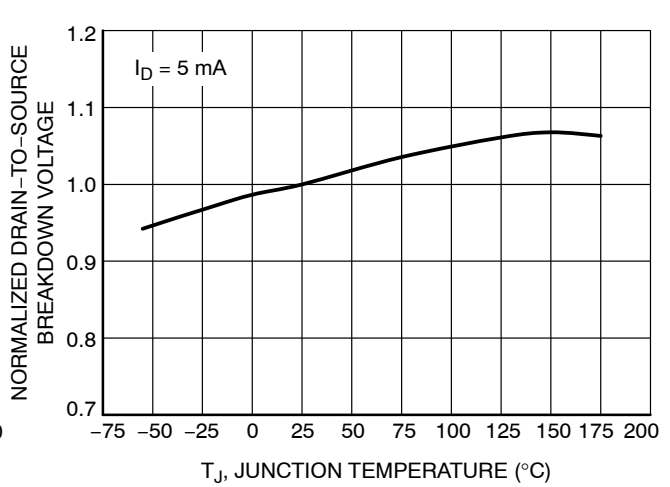


Figure 8. Normalized Drain-to-Source Breakdown Voltage vs. Junction Temperature

TYPICAL CHARACTERISTICS

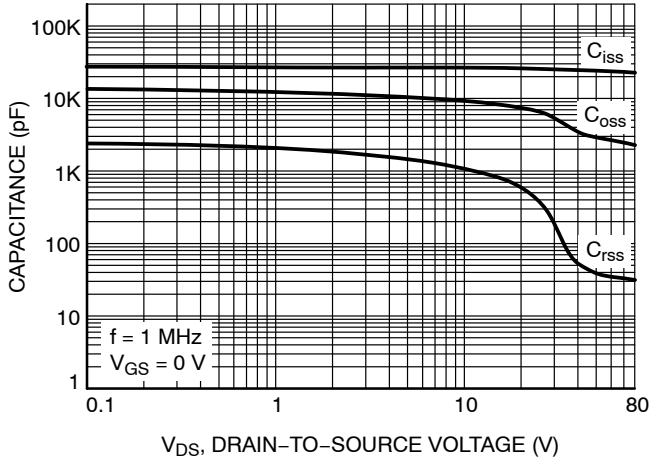


Figure 9. Capacitance vs. Drain-to-Source Voltage

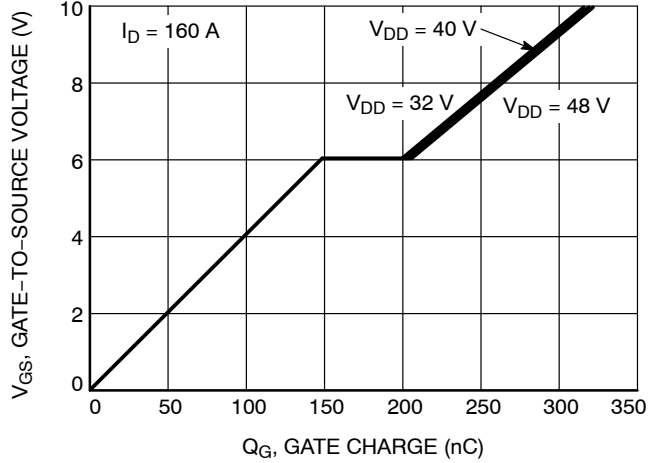


Figure 10. Gate Charge vs. Drain-to-Source Voltage

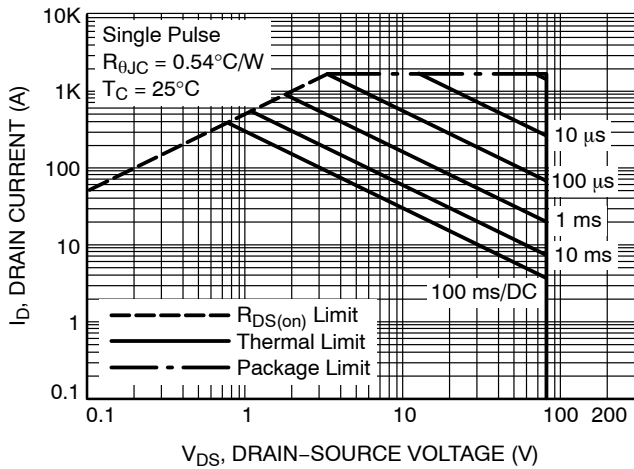


Figure 11. Safe Operating Area

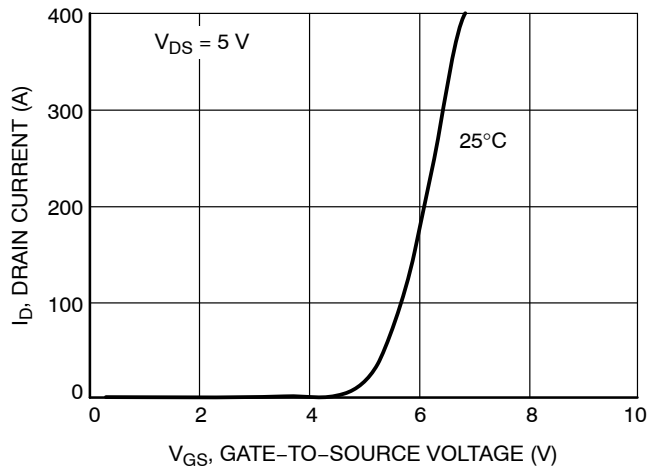


Figure 12. Transfer Characteristics

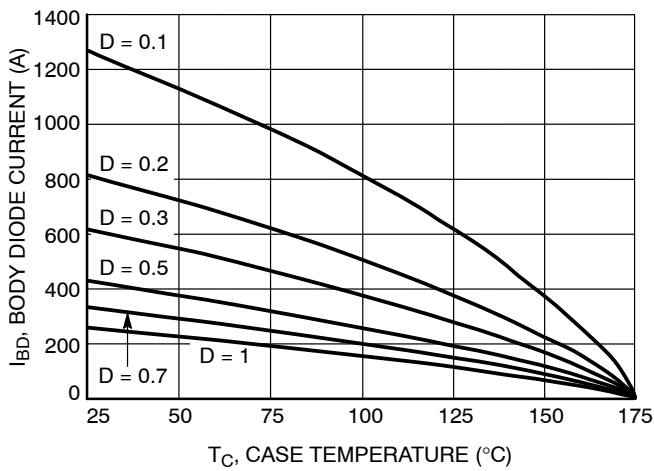
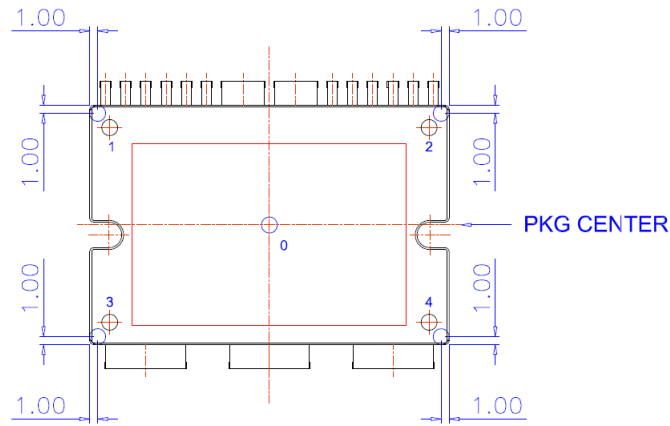


Figure 13. Body Diode Current

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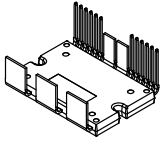
20
 FLATNESS : MAX. 150um
 - MEASURING AT INDICATING POINTS
 1, 2, 3, AND 4 (BASED ON "0")

Figure 14. Flatness Measurement Position

MECHANICAL CHARACTERISTICS AND RATINGS

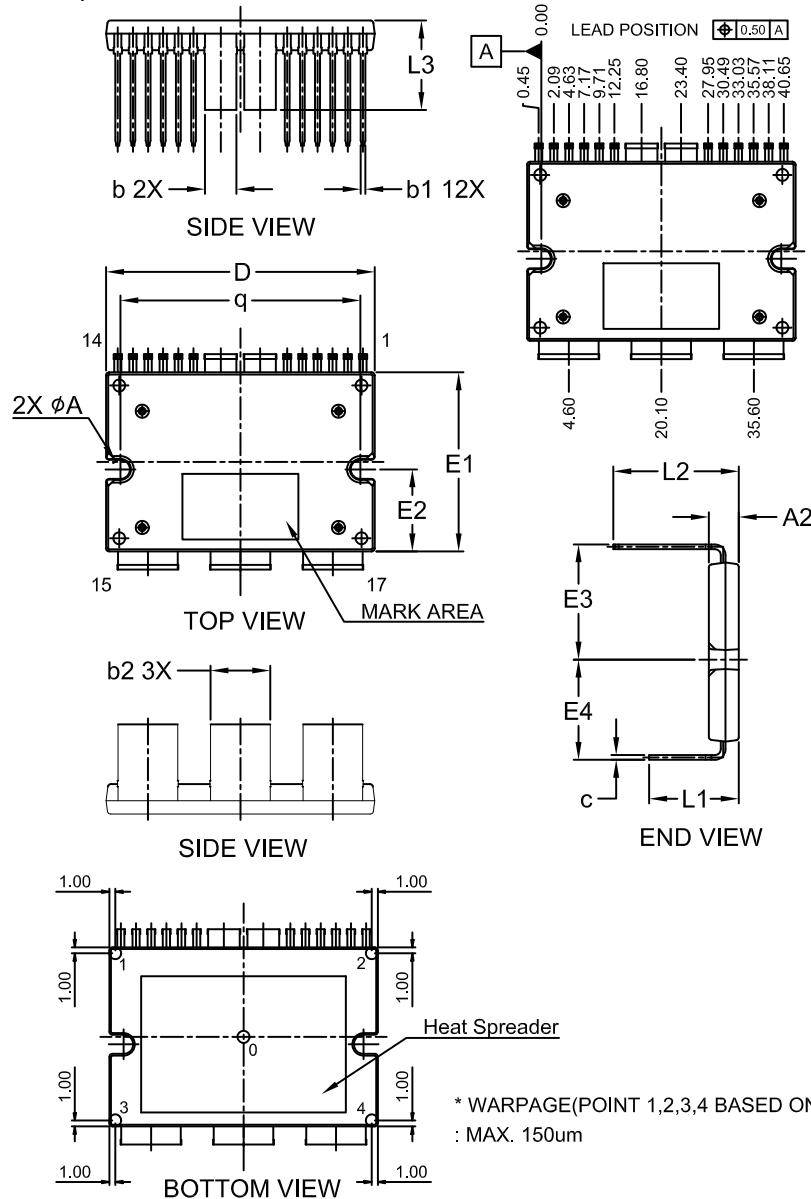
Parameter	Test Conditions	Min	Typ	Max	Units
Device Flatness	Refer to the package dimensions	0	-	150	um
Mounting Torque	Mounting screw: M3, recommended 0.7 N•m	0.4	-	1.4 (Note 5)	N•m
Weight		-	23.6	-	g

5. Max Torque rating can be different by the type of screw, such as the screw head diameter, use or without use of Washer. In case of special screw mounting method is applied, contact **onsemi** for the proper information of mounting condition.



APM17-MDC
CASE MODHH
ISSUE C

DATE 08 DEC 2021

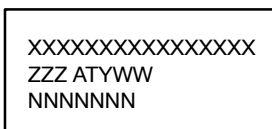


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A2	4.90	5.00	5.10
b	5.20	5.30	5.40
b1	0.70	0.80	0.90
b2	9.90	10.00	10.10
c	0.75	0.80	0.90
D	44.90	45.00	45.10
E1	29.90	30.00	30.10
E2	13.65	13.75	13.85
E3	19.00	19.30	19.60
E4	16.50	16.80	17.10
L1	14.70	15.00	15.30
L2	20.70	21.00	21.30
L3	14.70	15.00	15.30
q	40.10	40.20	40.30
ϕA	3.10	3.20	3.30

GENERIC
MARKING DIAGRAM*



XXXX = Specific Device Code
 ZZZ = Lot ID
 AT = Assembly & Test Location
 Y = Year
 W = Work Week
 NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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